# **Power MOSFET**

# 30 V, 38 A, Single N-Channel, μ8FL

### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- CPU Power Delivery
- DC-DC Converters

# **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Para	Symbol	Value	Unit		
Drain-to-Source Volt	Drain-to-Source Voltage				V
Gate-to-Source Volta	$V_{GS}$	±20	V		
Continuous Drain Current R <sub>θJA</sub> (Note 1)		$T_A = 25^{\circ}C$ $T_A = 80^{\circ}C$	I <sub>D</sub>	11.7 8.5	Α
Power Dissipation R <sub>0JA</sub> (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.06	W
Continuous Drain Current R <sub>θJA</sub> ≤ 10 s (Note 1)		$T_{A} = 25^{\circ}C$ $T_{A} = 80^{\circ}C$		15.8 11.4	Α
Power Dissipation $R_{\theta JA} \le 10 \text{ s (Note 1)}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	3.73	W
Continuous Drain	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	7.2	Α
Current R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 80°C		5.2	
Power Dissipation R <sub>θJA</sub> (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.78	W
Continuous Drain		T <sub>C</sub> = 25°C	Ι <sub>D</sub>	38	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> =80°C		27	
Power Dissipation R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	21.5	W
Pulsed Drain Current	$T_A = 25^{\circ}$	$^{\circ}$ C, $t_{p} = 10 \ \mu s$	I <sub>DM</sub>	68	Α
Current Limited by Pa	ickage	T <sub>A</sub> = 25°C	I <sub>Dmax</sub>	70	Α
Operating Junction ar Temperature	T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C		
Source Current (Body	I <sub>S</sub>	19	Α		
Drain to Source DV/D	dV/d <sub>t</sub>	7.0	V/ns		
Single Pulse Drain–to–Source Avalanche Energy ( $T_J = 25^{\circ}C$ , $V_{GS} = 10$ V, $I_L = 4$ A <sub>pk</sub> , $L = 0.1$ mH, $R_{GS} = 25 \Omega$ ) (Note 3)			E <sub>AS</sub>	22	mJ
Lead Temperature for (1/8" from case for 10	TL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

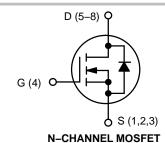
- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is absolute maximum rating. Parts are tested at  $T_J = 25^{\circ}C V_{qs} = 10 V$ ,  $I_L = 15 \text{ Apk}, E_{AS} = 11 \text{ mJ}.$



#### ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub> R <sub>DS(ON)</sub> MAX		I <sub>D</sub> MAX
30 V	9.4 mΩ @ 10 V	38 A
	14 mΩ @ 4.5 V	30 A





## WDFN8 (µ8FL) CASE 511AB

# MARKING DIAGRAM



4C13 = Specific Device Code = Assembly Location Α

= Year WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>		
NTTFS4C13NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel		
NTTFS4C13NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	5.8	
Junction-to-Ambient - Steady State (Note 4)	$R_{\theta JA}$	60.8	°C/W
Junction-to-Ambient - Steady State (Note 5)	$R_{\theta JA}$	160	30/00
Junction-to-Ambient - (t ≤ 10 s) (Note 4)	$R_{\theta JA}$	33.5	

- 4. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 5. Surface-mounted on FR4 board using the minimum recommended pad size.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>.1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS				•	•	•	•
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage (transient)	V <sub>(BR)DSSt</sub>	$V_{GS} = 0 \text{ V, } I_{D(aval)} = TBD \text{ A,}$ $T_{case} = 25^{\circ}\text{C, } t_{transient} = 100 \text{ ns}$		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				14.9		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25°C			1.0	μΑ
			T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μΑ	1.3		2.1	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.8		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 30 A		7.5	9.4	0
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 12 A		11.2	14	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 15 A			40		S
Gate Resistance	$R_{G}$	T <sub>A</sub> = 25°C			1.0		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				770		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MH:	z, V <sub>DS</sub> = 15 V		443		
Reverse Transfer Capacitance	C <sub>RSS</sub>				127		
Capacitance Ratio	C <sub>RSS</sub> /C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 15 V, f = 1 MHz			0.165		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			7.8		
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.4		nC
Gate-to-Source Charge	$Q_{GS}$				2.9		
Gate-to-Drain Charge	$Q_{GD}$				3.7		1
Gate Plateau Voltage	$V_{GP}$				3.6		V
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 30 A			15.2		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

<sup>6.</sup> Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .
7. Switching characteristics are independent of operating junction temperatures.

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	lote 7)				•	•	
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			9		- ns
Rise Time	t <sub>r</sub>				35		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				13		
Fall Time	t <sub>f</sub>				5		
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			6.0		ns
Rise Time	t <sub>r</sub>				26		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				16		
Fall Time	t <sub>f</sub>				3.0		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V},$ $T_J = 25^{\circ}\text{C}$			0.82	1.1	
		I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.69		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			23.4		
Charge Time	t <sub>a</sub>				12.1		ns
Discharge Time	t <sub>b</sub>				11.3		
Reverse Recovery Charge	Орр			9.7		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

7. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

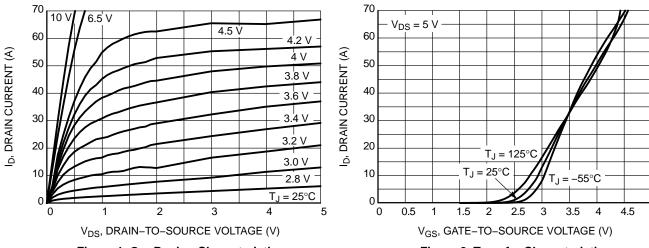


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics

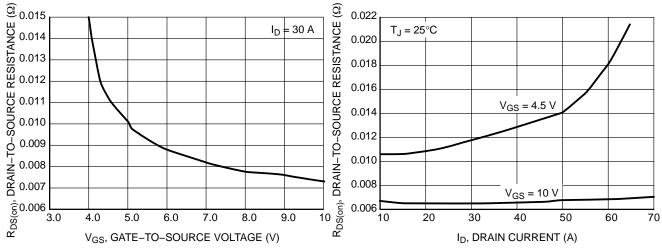


Figure 3. On-Resistance vs. V<sub>GS</sub>

Figure 4. On-Resistance vs. Drain Current and Gate Voltage

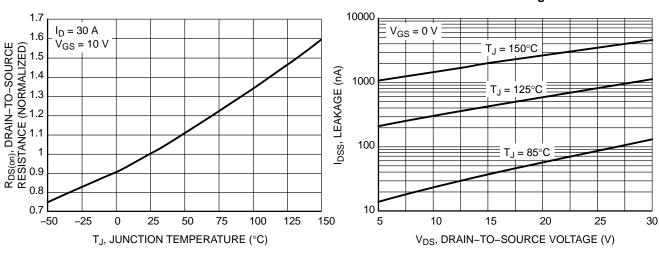


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL CHARACTERISTICS**

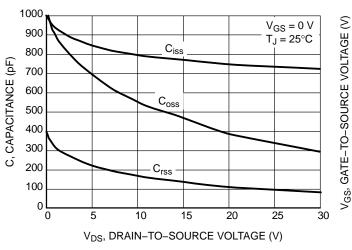


Figure 7. Capacitance Variation

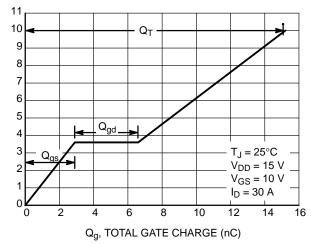


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

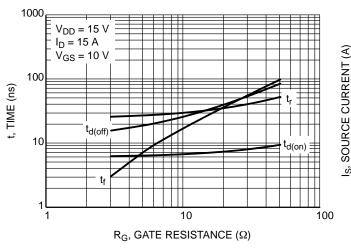


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

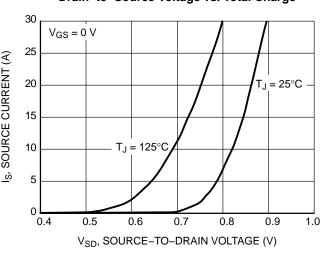


Figure 10. Diode Forward Voltage vs. Current

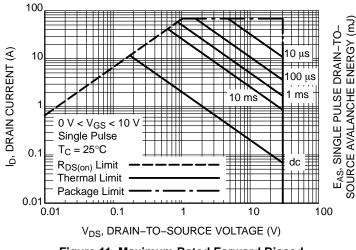


Figure 11. Maximum Rated Forward Biased Safe Operating Area

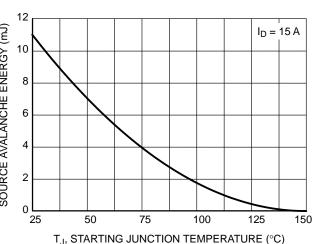


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

#### **TYPICAL CHARACTERISTICS**

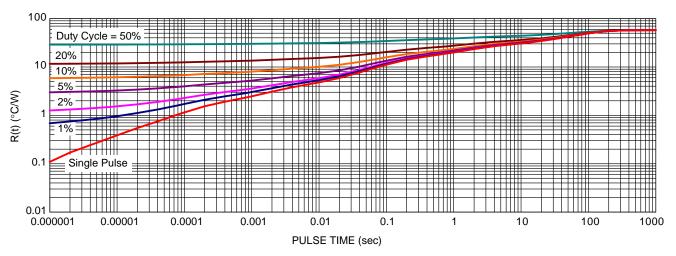


Figure 13. Thermal Response

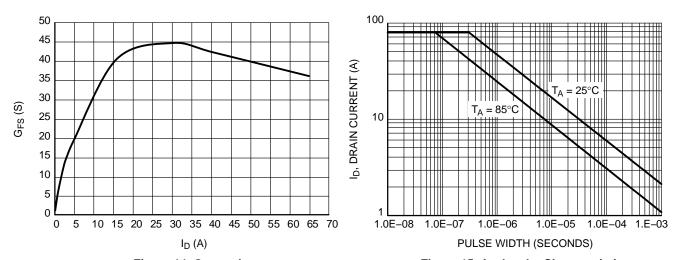
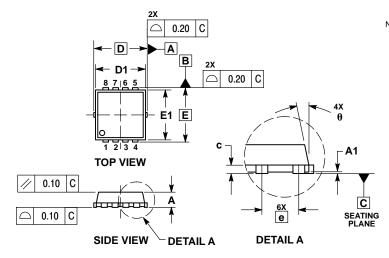


Figure 14. G<sub>FS</sub> vs. I<sub>D</sub> Figure 15. Avalanche Characteristics

#### PACKAGE DIMENSIONS

#### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D



#### NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS.

	MI	LLIMETE	RS	INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	3.30 BSC			0.130 BSC			
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E	. ;	3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC			0.026 BS	0	
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

#### С В 0.10 Α 0.05 С e/2 E2 F3 D2 G **BOTTOM VIEW**

# **SOLDERING FOOTPRINT\*** 8X 0.42 -0.66 3.60 0.75 0.57 2.30 0.47 2.37 3.46

**DIMENSION: MILLIMETERS** \*For additional information on our Pb-Free strategy and soldering

details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and in are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

### **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA

Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910

Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

# **Mouser Electronics**

**Authorized Distributor** 

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

**ON Semiconductor:** 

NTTFS4C13NTAG NTTFS4C13NTWG